

SPECIFICATION FOR LCD MODULE

MODULE NO: YB-TG240320S25A-N-A1

Doc. Version:05

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|--------------------|--------------|---------------|----------|
| Customer Approval: | | | |
| ☐ Accept | | | ☐ Reject |
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| YEEBO | NAME | SIGNATURE | DATE |
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| YEEBO | NAME | SIGNATURE | DATE |
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☐ APPROVAL FOR SPECIFICATIONS ONLY

■ APPROVAL FOR SPECIFICATIONS AND SAMPLE

WIMRD005-02-D

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1. Revision History

| Sample Version | DOC. Version | DATE | | CHANGED BY | |
|-------------------|-----------------|------------|-----------|--|---------------|
| A0 | 00 | 2014-11-05 | SPEC ONLY | First issue | Fanny/Aiching |
| A0 | 01 | 2014-12-18 | FULL SPEC | First Sample | Fanny/Jimmy |
| A1 | 02 | 2015-01-13 | FULL SPEC | Change Polarizer supplier | Fanny/Jimmy |
| A1 | 03 | 2015-02-05 | FULL SPEC | Modify LCM drawingP.5 | Fanny/Ujl |
| A1 | 04 | 2015-04-15 | FULL SPEC | Modify Power Supply CurrentP.6 Specification of Quality AssuranceP.20,25 | Fanny/Ujl |
| A1 | 05 | 2015-05-08 | FULL SPEC | Modify Power Supply VoltageP.6 | Fanny/Ujl |
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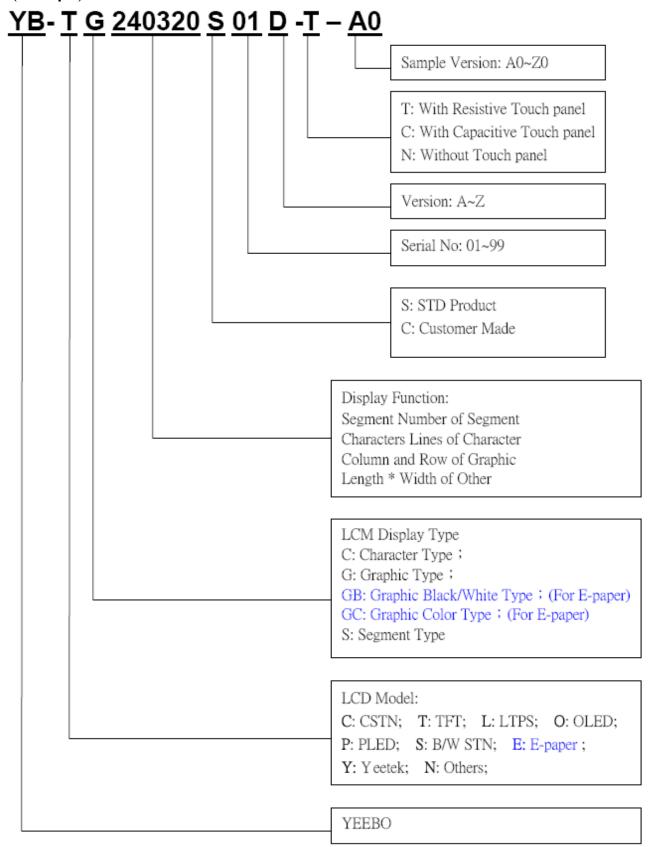
2. Table of Contents:

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3. Module Numbering System:

(Example)



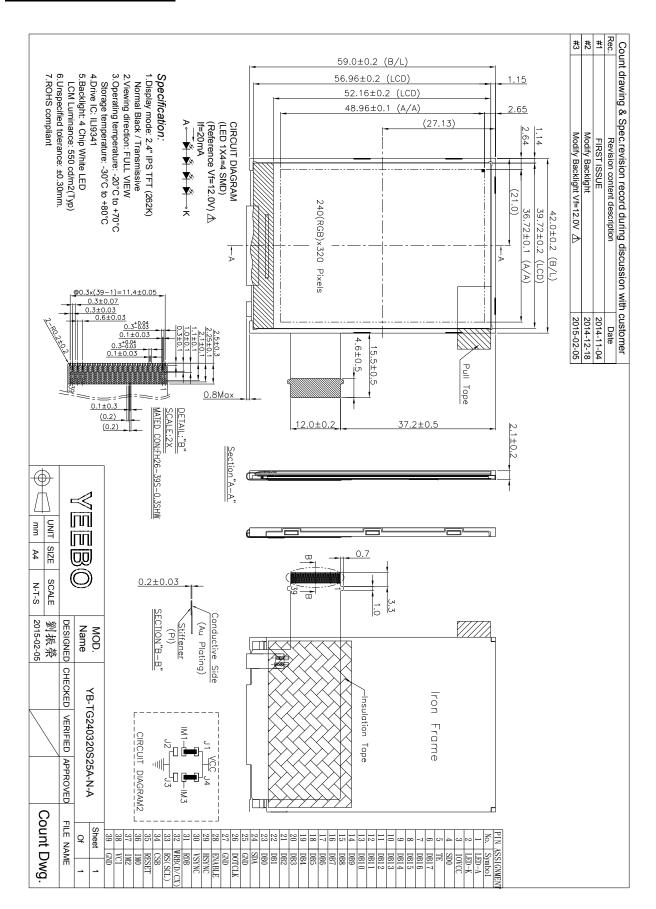


4. General Specification:

| ITEM | CONTENTS |
|------------------------|--|
| Module Size | 42.0 (W) * 59.0 (H) * 2.1 (T) mm |
| Module Size(With FPC) | 57.5 (W) * 59.0 (H) * 2.1 (T) mm |
| Display Size(Diagonal) | 2.4 inch |
| Display Format | 240(RGB)*320 Pixels |
| Active Area | 36.72(W) * 48.96 (H) mm |
| Pixel Pitch | 0.153 * 0.153 mm |
| LCD Type | TFT (262K) / Transmissive / Normally Black |
| View Angle | Free |
| Controller IC | ILI9341 |
| Weight | 10.8g |



5. LCM drawing:





6. Electrical Characteristics

6-1 Absolute Maximum Ratings

(Ta=25°C VSS=0V)

| Item | Symbol | Min. | Type | Max. | Unit | Remark |
|-----------------------|-----------------|------|------|------|------------------------|--------|
| Supply Voltage | V_{CI} | -0.3 | ı | +4.6 | Volt | Note1 |
| Supply Voltage(Logic) | IOV_{CC} | -0.3 | - | +4.6 | Volt | Note1 |
| Operating Temperature | Topr | -20 | - | +70 | $^{\circ}\!\mathbb{C}$ | - |
| Storage Temperature | Tstg | -30 | - | +80 | $^{\circ}\!\mathbb{C}$ | - |

Note1: Absolute maximum rating is the limit value beyond which the IC maybe broken. They do not assure operations.

6-2 Operating Conditions

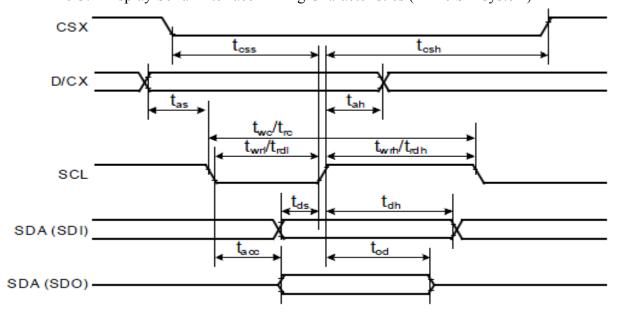
(Ta=25°C)

| | | | | | 1 | |
|---------------------------------|-------------------|-----------|-------------------------|------|------------------------|------|
| Item | Symbol | Condition | Min. | Тур. | Max. | Unit |
| Power Supply voltage | V_{CI} | - | 2.6 | 2.8 | 3.3 | Volt |
| Supply voltage for I/O | IOV _{CC} | 1 | 1.65 | 2.8 | 3.3 | Volt |
| Input Voltage | V_{IH} | 1 | 0.7 * IOV _{CC} | - | IOV_{CC} | V |
| | V_{IL} | - | Vss | - | 0.3* IOV _{CC} | V |
| Power Supply Current for LCM | Icc | VCI=2.8V | - | 12 | 18 | mA |



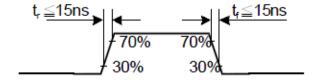
6-3 Timing Characteristics

6-3.1 Display Serial Interface Timing Characteristics (4-line SPI system)

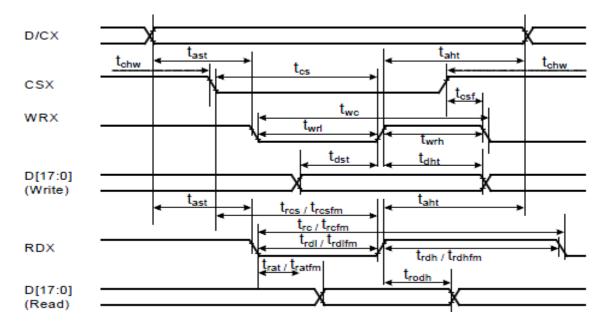


| Signal | Symbol | Parameter | min | max | Unit | Description |
|-----------|--------|-------------------------------|-----|-----|------|---------------------|
| CSX | tcss | Chip select time (Write) | 40 | - | ns | |
| COA | tcsh | Chip select hold time (Read) | 40 | - | ns | |
| | twc | Serial clock cycle (Write) | 100 | - | ns | |
| | twrh | SCL "H" pulse width (Write) | 40 | - | ns | |
| SCL | twrl | SCL "L" pulse width (Write) | 40 | - | ns | |
| SCL | trc | Serial clock cycle (Read) | 150 | - | ns | |
| | trdh | SCL "H" pulse width (Read) | 60 | - | ns | |
| | trdl | SCL "L" pulse width (Read) | 60 | - | ns | |
| D/CX | tas | D/CX setup time | 10 | - | | |
| DICX | tah | D/CX hold time (Write / Read) | 10 | - | | |
| SDA / SDI | tds | Data setup time (Write) | 30 | - | ns | |
| (Input) | tdh | Data hold time (Write) | 30 | - | ns | |
| SDA / SDO | tacc | Access time (Read) | 10 | - | ns | For maximum CL=30pF |
| (Output) | tod | Output disable time (Read) | 10 | 50 | ns | For minimum CL=8pF |

Note: Ta = 25 °C, VDDI=1.65V to 3.3V, VCI=2.5V to 3.3V, AGND=VSS=0V

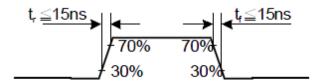






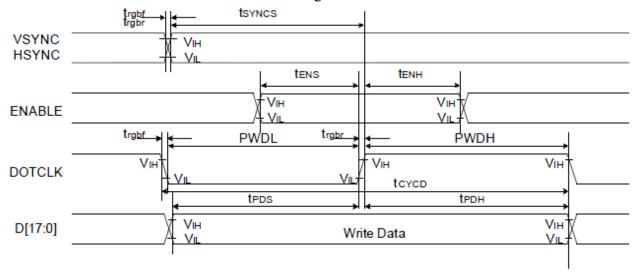
| Signal | Symbo | Parameter | min | max | Unit | Description |
|-------------------------------|--------|------------------------------------|-----|-----|------|---------------------|
| DCX | tast | Address setup time | 0 | - | ns | |
| DCX | taht | Address hold time (Write/Read) | 0 | - | ns | |
| | tchw | CSX "H" pulse width | 0 | - | ns | |
| | tcs | Chip Select setup time (Write) | 15 | - | ns | |
| CSX | trcs | Chip Select setup time (Read ID) | 45 | - | ns | |
| | tresfm | Chip Select setup time (Read FM) | 355 | - | ns | |
| | tcsf | Chip Select Wait time (Write/Read) | 10 | - | ns | |
| | twc | Write cycle | 66 | - | ns | |
| WRX | twrh | Write Control pulse H duration | 15 | - | ns | |
| | twrl | Write Control pulse L duration | 15 | - | ns | |
| | trcfm | Read Cycle (FM) | 450 | - | ns | |
| RDX (FM) | trdhfm | Read Control H duration (FM) | 90 | - | ns | |
| | trdlfm | Read Control L duration (FM) | 355 | - | ns | |
| | trc | Read cycle (ID) | 160 | - | ns | |
| RDX (ID) | trdh | Read Control pulse H duration | 90 | - | ns | |
| | trdl | Read Control pulse L duration | 45 | - | ns | |
| D(47:0) | tdst | Write data setup time | 10 | - | ns | |
| D[17:0], | tdht | Write data hold time | 10 | - | ns | For maximum CL=30pF |
| D[17:10]&D[8:1], D[17:10], | trat | Read access time | - | 40 | ns | For maximum CL=30pF |
| | tratfm | Read access time | - | 340 | ns | For minimum CL-ope |
| D[17:9] | trod | Read output disable time | 20 | 80 | ns | |

Note: Ta = -30 to 70 °C, VDDI=1.65V to 3.3V, VCI=2.5V to 3.3V, VSS=0V.



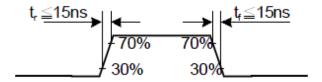


6-3.3 Parallel 18/16/6-bit RGB Interface Timing Characteristics



| Signal | Symbol | Parameter | min | max | Unit | Description |
|---------|---------------------------------------|-----------------------------------|-----|-----|------|-------------------|
| VSYNC / | tsyncs | VSYNC/HSYNC setup time | 15 | - | ns | |
| HSYNC | t _{synch} | VSYNC/HSYNC hold time | 15 | - | ns | |
| DE | tens | DE setup time | 15 | - | ns | |
| DE | t _{ENH} | DE hold time | 15 | - | ns | |
| D[17:0] | teos | Data setup time | 15 | - | ns | 18/16-bit bus RGB |
| D[17.0] | t _{PDH} | Data hold time | 15 | - | ns | interface mode |
| | PWDH | DOTCLK high-level period | 15 | - | ns | |
| DOTCLK | PWDL | DOTCLK low-level period | 15 | - | ns | |
| DOTCER | toyop | DOTCLK cycle time | 100 | - | ns | |
| | t _{rgbr} , t _{rgbr} | DOTCLK,HSYNC,VSYNC rise/fall time | - | 15 | ns | |
| VSYNC / | tsyncs | VSYNC/HSYNC setup time | 15 | - | ns | |
| HSYNC | tsynch | VSYNC/HSYNC hold time | 15 | - | ns | |
| DE | tens | DE setup time | 15 | - | ns | |
| DE | t _{ENH} | DE hold time | 15 | - | ns | |
| D[47:0] | teos | Data setup time | 15 | - | ns | 6-bit bus RGB |
| D[17:0] | t _{PDH} | Data hold time | 15 | - | ns | interface mode |
| | PWDH | DOTCLK high-level pulse period | 15 | - | ns | |
| DOTCLK | PWDL | DOTCLK low-level pulse period | 15 | - | ns | |
| DOTOLK | toyon | DOTCLK cycle time | 50 | - | ns | |
| | t _{rgbr} , t _{rgbf} | DOTCLK,HSYNC,VSYNC rise/fall time | - | 15 | ns | |

Note: Ta = -30 to 70 °C, VDDI=1.65V to 3.3V, VCI=2.5V to 3.3V, AGND=VSS=0V





7. Optical Characteristics:

| T4 0 200 | Itama | | Symbol Conditions | | Specifications | | | Note |
|----------------------------|--------|--------|-----------------------------------|-----|----------------|-----|------|--------|
| Item | | Symbol | Conditions | Min | Тур | Max | Unit | Note |
| Transmittance (With PL) | | T(%) | _ | - | 4.65 | - | - | - |
| Contrast Ratio | | CR | ⊖=0 Normal Viewing angle | - | 800 | - | | (1)(2) |
| Response | e time | TR+TF | _ | - | 35 | - | ms | (1)(3) |
| | Hor | Өх+ | | - | 80 | - | | |
| Viewing angle Ver | | Өх- | CR≧10 | - | 80 | - | doa | |
| | | Өу+ | CK=10 | - | 80 | - | deg. | - |
| | vei | Өу- | | - | 80 | - | | |

Measuring Condition

1. Measuring surrounding: dark room

2. Ambient temperature: 25±2°C

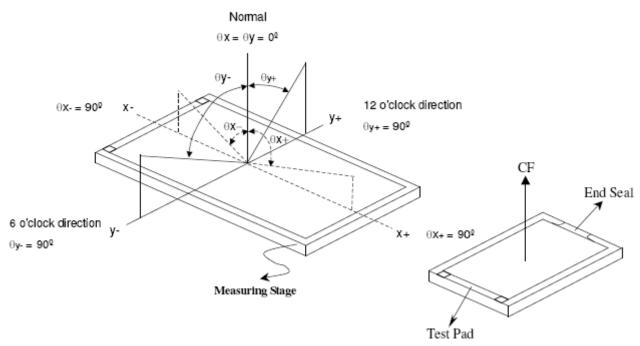
3. 30 min. Warm-up time.

Color of CIE Coordinate:

| Item | | Symbol | Condition | Min. | Тур. | Max. | Brightness |
|--------------------------|-------|--------|------------------------------|-------|-------|-------|-------------------------|
| | D 1 | X | | 0.597 | 0.647 | 0.697 | 100 1/ 2 |
| | Red | у | $\theta = \phi = 0_{\circ}$ | 0.267 | 0.317 | 0.367 | 100 cd/m^2 |
| | Green | X | LED Backlight Color Degree | 0.265 | 0.315 | 0.365 | 450 cd/m ² |
| Chromaticity Coordinates | | у | | 0.532 | 0.582 | 0.632 | 430 Cd/III ² |
| (Transmissive) | Blue | X | x=0.3 y=0.3 Brightness | 0.090 | 0.140 | 0.190 | 35 cd/m ² |
| (Transmissive) | | y | | 0.038 | 0.088 | 0.138 | 33 cd/m² |
| | White | X | $= 7000 \text{ cd/m}^2$ | 0.260 | 0.310 | 0.360 | 550 ad/m ² |
| | | у | 7000 cu /m | 0.286 | 0.336 | 0.386 | 550 cd/m ² |



Note (1) Definition of Viewing Angle:

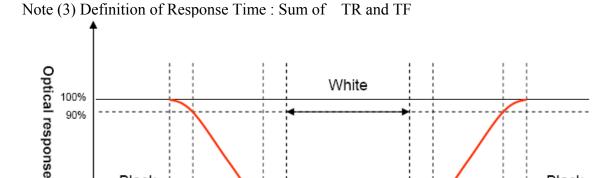


Note (2) Definition of Contrast Ratio(CR): measured at the center point of panel

10% 0%

Contrast ratio (CR)= Photo detector output when LCD is at "White" state

Photo detector output when LCD is at "Black





8. Interface Pin Assignment:

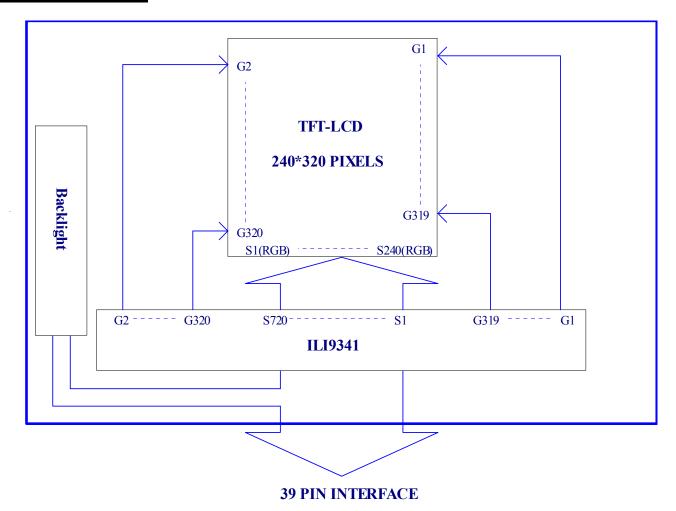
| No. | Symbol | Function |
|-----|--------|---|
| 1 | LED_A | LED power anode |
| 2 | LED_K | LED power cathode |
| 3 | IOVCC | Digital power supply |
| 4 | SDO | Serial data output signal |
| 5 | TE | Tearing effect output pin (No connection) |
| 6 | DB17 | Data bus |
| 7 | DB16 | Data bus |
| 8 | DB15 | Data bus |
| 9 | DB14 | Data bus |
| 10 | DB13 | Data bus |
| 11 | DB12 | Data bus |
| 12 | DB11 | Data bus |
| 13 | DB10 | Data bus |
| 14 | DB9 | Data bus |
| 15 | DB8 | Data bus |
| 16 | DB7 | Data bus |
| 17 | DB6 | Data bus |
| 18 | DB5 | Data bus |
| 19 | DB4 | Data bus |
| 20 | DB3 | Data bus |
| 21 | DB2 | Data bus |
| 22 | DB1 | Data bus |
| 23 | DB0 | Data bus |
| 24 | SDA | Serial data input signal |
| 25 | GND | Ground |
| 26 | DOTCLK | Pixel clock signal in RGB I/F mode |
| 27 | GND | Ground |



| - TEEDO GROOT | | | | | | | | | |
|---------------|--------|---------------|------------------------------------|--------|--------|-----------------------------------|--|---------------------|------|
| 28 | ENABLE | Data | Data enable signal in RGB I/F mode | | | | | | |
| 29 | HSYNC | Horiz | ontal | synd | c. Sig | nal in RGB I/F mode | | | |
| 30 | VSYNC | Vertic | cal sy | nc. S | Signa | I in RGB I/F mode | | | |
| 31 | RDB | Read | sign | al in | 80-se | eries parallel interface | | | |
| 32 | WRB | Write | sign | al in | 80-se | eries parallel interface | | | |
| 33 | RS | Data/ | 'Com | man | d sele | ect signal | | | |
| 34 | CSB | Chip | selec | ct sig | nal | | | | |
| 35 | RESET | Rese | t sigr | nal | | | | | |
| | | Selection IM3 | t MC | U In | terfac | ce mode MCU-Interface Mode | DB Pin in u | se | |
| 36 | | | livio | IIVIZ | IIVII | IIVIO | WCO-IIIleriace Wode | Register/content | GRAM |
| | IM0 | 1 | 0 | 1 | 0 | 80 MCU 18-bit bus Interface II | D[8:1] | D[17:0] | |
| | IM2 | 1 | 0 | 1 | 1 | 80 MCU 9-bit bus Interface II | D[17:10] | D[17:9] | |
| 37 | | | 1 | 1 | 1 | 0 | 4-wire 8-bit data serial Interface II | SDI: in SOO: out | : |
| 38 | VCI | Analo | og po | wer | suppl | у | | | |
| 39 | GND | Grou | nd | | | | | | |



9. Block Diagram:



Module P/N:YB-TG240320S25A-N-A1 Doc.Version:05



10. Backlight:

- 1. Standard Lamp Styles (Edge Lighting Type):
 The LED chips are distributed over the edge light area of the illumination unit, which gives the less power consumption:
- 2. The Main Advantages of the LED Backlight are as following:
 - 2.1 The brightness of the backlight can simply be adjusted. By a resistor or a potentiometer.

3. Data About LED Backlight:

(Ta=25°C)

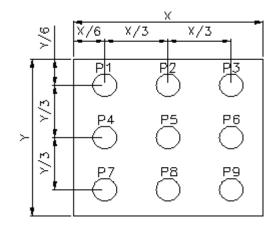
| Data About LED Backlight. (1a-25 C) | | | | | | | |
|-------------------------------------|-------|------|-------|------|-------|-------------------|------|
| PARAMETER | Sym. | Min. | Тур. | Max. | Unit | Test Condition | Note |
| Supply Current | I | ı | 20 | ı | mA | V=12.0V | |
| Supply Voltage | V | 11.0 | 12.0 | 13.2 | V | If=20mA | |
| Reverse Voltage | VR | - | - | 5 | V | - | |
| Luminous Intensity for LCM | IV | 450 | 550 | ı | Cd/m2 | If=20mA | 2 |
| Uniformity for LCM | - | 70 | - | - | % | If=20mA | 3 |
| Life Time | - | - | 50000 | - | Hr. | If=20mA | 4 |
| Color | White | | | | | | |

NOTE:

- 1. Backlight Only
- 2. Average Luminous Intensity of P1-P9
- 3. Uniformity = Min/Max * 100%
- 4. LED life time defined as follows: The final brightness is at 50% of original brightness

Measured Method: (X*Y: Light Area)

Internal Circuit Diagram





(Effective spatial Distribution)

Hole Diameter ø8 mm; 1 to 9 per Position Measured Luminous



11. Standard Specification for Reliability: 11–1. Standard Specifications for Reliability of LCD Module

| No | Item | Description |
|----|-----------------------------|---|
| 01 | High temperature operation | The sample should be allowed to stand at 70°C for 120 hours under driving condition and then returning it to normal temperature condition, and allowing it stand for 2 hours. |
| 02 | Low temperature operation | The sample should be allowed to stand at -20°C for 120 hours under driving condition and then returning it to normal temperature condition, and allowing it stand for 2 hours. |
| 03 | High temperature storage | The sample should be allowed to stand at 80°C for 240 hours under no-load condition, and then returning it to normal temperature condition, and allowing it stand for 2 hours. |
| 04 | Low temperature storage | The sample should be allowed to stand at -30°C for 240 hours under no-load condition, then returning it to normal temperature condition, and allowing it stand for 2 hours. |
| 05 | Moisture storage | The sample should be allowed to stand at 60°C,90%RH MAX for 240 hours under no-load condition, then taking it out and drying it at normal temperature for 2 hours. |
| 06 | Thermal shock storage | The sample should be allowed to stand the following 10 cycles: -30° C for 30 minutes \rightarrow normal temperature for 5 minutes \rightarrow +80°C for 30 minutes \rightarrow normal temperature for 5 minutes, as one cycle. |
| 07 | Packing vibration | Frequency range: 10Hz ~ 55Hz Amplitude of vibration: 1.5mm X,Y,Z 2 hours for each direction. Sweep time: 12 min |
| 08 | Packing drop test | According to ISTA 1A 2001. |
| 09 | Electrical Static | Air: ± 4 KV 150pF/330 Ω 5 times |
| | Discharge | Contact: $\pm 2KV \ 150pF/330\Omega \ 5$ time |

^{*}Sample size for each test item is 3~5pcs



11 - 2. Testing Conditions and Inspection Criteria

For the final test the testing sample must be stored at room temperature for 24 hours, after the tests listed in Table 11-1, Standard specifications for Reliability have been executed in order to ensure stability.

| No | Item | Test Model | In section Criteria |
|----|------------------------|------------------------|--|
| 01 | Current Consumption | Refer To Specification | The current consumption should conform to the product specification. |
| 02 | Contrast | Refer To Specification | After the tests have been executed, the contrast must be larger than half of its initial value prior to the tests. |
| 03 | Appearance | Visual inspection | Defect free. |

11-3. MTBF

| MTBF | Functions, performance, appearance, etc. shall be free from remarkable deterioration within 50,000 hours under ordinary operating and storage conditions room temperature (25±5 $^{\circ}$ C), normal humidity (50±10% RH), and in area not exposed to direct sun light. |
|------|--|
|------|--|



12. Specification of Quality Assurance:

12-1. Purpose

This standard for Quality Assurance should affirm the quality of LCD module products to supply to purchaser by YEEBO CORPORATION (Supplier).

12-2. Standard for Quality Test

a. Inspection:

Before delivering, the supplier should take the following tests, and affirm the quality of product.

b. Electro-Optical Characteristics:

According to the individual specification to test the product.

c. Test of Appearance Characteristics:

According to the individual specification to test the product.

d. Test of Reliability Characteristics:

According to the definition of reliability on the specification for testing products.

e. Delivery Test:

Before delivering, the supplier should take the delivery test.

- (i) Test method: According to MIL-STD105E.General Inspection Level

 take a single time.
- (ii) The defects classify of AQL as following:

Major defect: AQL = 0.65 Minor defect: AQL = 2.5 Total defects: AQL = 2.5

12-3. Non- conforming Analysis & Deal With Manners

- a. Non-conforming Analysis:
 - (i) Purchaser should supply the detail data of non- conforming sample and the non-conforming.
 - (ii) After accepting the detail data from purchaser, the analysis of non- conforming should be finished in two weeks.
 - (iii) If supplier can not finish analysis on time, must announce purchaser before 3 days.
- b. Disposition of non- conforming:
 - (i) If find any product defect of supplier during assembly time, supplier must change the good product for every defect after recognition.
 - (ii) Both supplier and customer should analyze the reason and discuss the disposition of non- conforming when the reason of nonconforming is not sure.

12-4. Agreement items

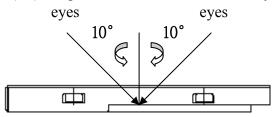
Both sides should discuss together when the following problems happen.

- a. There is any problem of standard of quality assurance, and both sides should think that must be modified.
- b. There is any argument item which does not record in the standard of quality assurance.
- c. Any other special problem.

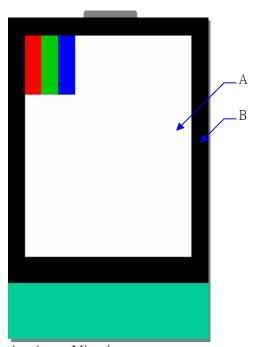


12-5. Standard of The Product Appearance Test

- a. Manner of appearance test:
- (i) The test must be under $20W \times 2$ or 40W fluorescent light, and the distance of view must be at $30\pm5cm$.
 - (ii) When test the model of transmissive product must add the reflective plate.
 - (iii)The test direction is base on around 10° of vertical line.
 - (iiii)Temperature: 25±5°C Humidity: 60±10%RH



(iv) Definition of area:



- A. Area: Viewing area.
- B. Area: Out of viewing area.

(Outside viewing area)

- b. Basic principle:
- (i) It will accord to the AQL when the standard can not be described.
- (ii) The sample of the lowest acceptable quality level must be discussed by both supplier and customer when any dispute happened.
- (iii) Must add new item on time when it is necessary.
- c. Standard of inspection: (Unit: mm)



12-6. Inspection specification

Defect out of viewing area can be neglected.

| NO | Item | Criterion | | | | | |
|----|--|--|--------------------------------------|---|--|-----|--|
| 01 | Electrical Testing | 1.1 Missing vertical, horizontal segment, segment contrast defect. 1.2 Missing character, dot or icon. 1.3 Display malfunction. 1.4 No function or no display. 1.5 Current consumption exceeds product specifications. 1.6 LCD viewing angle defect. 1.7 Mixed product types. 1.8 Flicker | | | | | |
| 02 | Black or White spots or Bright spots or Color spots on LCD (Display only) | 2.1 White and black or color spots on display ≤ 0.25mm, no more than Five spots. 2.2 Densely spaced: No more than three spots within 3mm. | | | | | |
| 03 | LCD and Touch Panel black spots, white spots, | | consely spaced: | Size(mm) $Φ \le 0.10$ $0.10 < Φ \le 0.20$ $0.20 < Φ \le 0.25$ $0.25 < Φ \le 0.30$ 0.30 < Φ No more than two | Acceptable Q'ty Accept no dense 2 2 1 0 o spots within 3mm. | 2.5 | |
| | contamination (non – display) | 3.2 Line type: (As for L | Length(mm) $L \leq 3.0$ $L \leq 2.5$ | C / | Acceptable Q'ty Accept no dense 2 Rejection | 2.5 | |
| | | * D | ensely spaced: | No more than tw | o lines within 3mm. | | |



| NO | Item | Criterion | | | | | |
|----|----------------------|---|---|---|---|-----|--|
| 04 | Polarizer bubbles | If bubbles are visible, judge using black spot specifications, not easy to find, must check in specify direction | 0.20 0.50 | te Φ(mm) $0 \le 0.20$ < Φ ≤ 0.50 < Φ ≤ 1.00 1.00< Φ otal Q'ty | Acceptable Q'ty Accept no dense 3 2 0 3 | 2.5 | |
| 05 | Scratches | Follow NO.3 -2 Line Ty | pe. | | | | |
| 06 | Chipped glass | k: Seal width t: L: Electrode pad length 6.1 General glass chip: 6.1.1 Chip on panel surface z : Chip thickness y : $z \le 1/2t$ 1/2t< $z \le 2t$ ① Unit: mm ② If there are 2 or more 6.1.2 Corner crack: z : Chip thickness z : | Chip width Not over viewing area Not exceed 1/3k chips, x is the to Chip width Not over viewing area Not exceed 1/3k | ween panels $x: Chip$ $x \le x \le$ | length 1/8a each chip | 2.5 | |



| NO | Item | Criterion | AQL |
|----|-------------|--|-----|
| | | Symbols: x: Chip length y: Chip width z: Chip thickness k: Seal width t: Glass thickness a: LCD side length 7.2 Protrusion over terminal: 7.2.1 Chip on electrode pad: | |
| | | y: Chip width x: Chip length z: Chip thickness | |
| | | $y \le 0.5 \text{mm} \qquad x \le 1/8 a \qquad 0 < z \le t$ | |
| | | 7.2.2 Non-conductive portion: | |
| 07 | Glass crack | y Z Z Z Z Z Z Z Z Z Z Z Z Z Z Z Z Z Z Z | 2.5 |
| | | y: Chip width x: Chip length z: Chip thickness | |
| | | $y \le L \qquad \qquad x \le 1/8a \qquad \qquad 0 < z \le t$ | |
| | | ⊙ If there chipped area touches the ITO terminal, over 2/3 of the ITO must remain and be inspected according to electrode terminal specifications. ⊙ If the product will be heat sealed by the customer, the alignment mark must mot be damaged. 7.2.3 Substrate protuberance and internal crack y: width x: length y≤1/3L X≤a | |



| NO | Item | Criterion | AQL |
|----|--------------------|--|----------------------------------|
| 08 | Cracked glass | The LCD with extensive crack is not acceptable. | 2.5 |
| 09 | Backlight elements | 9.1 Illumination source flickers when lit. 9.2 Spots or scratches that appear when lit must be judged. Using LCD spot, lines and contamination standards. 9.3 Backlight doesn't light or color is wrong. | 2.5 2.5 0.65 |
| 10 | Bezel | Bezel must comply with product specifications. | 2.5 |
| 11 | PCB、COB | 11.1 COB seal may not have pinholes larger than 0.2mm or contamination. 11.2 COB seal surface may not have pinholes through to the IC. 11.3 The height of the COB should not exceed the height indicated in the assembly diagram. 11.4 There may not be more than 2mm of sealant outside the seal area on PCB. And there should be no more than three places. 11.5 Parts on PCB must be the same as on the production characteristic chart, There should be no wrong parts, missing parts or excess parts. 11.6 The jumper on the PCB should conform to the product characteristic chart. | 2.5 2.5 2.5 2.5 0.65 |
| 12 | FPC | 12.1 FPC terminal damage \leq 1/2 FPC terminal width and can not affect the function, we judge accept. 12.2 FPC alignment hole damage \leq 1/2 alignment area and can not affect the function, we judge accept. | 2.5 |
| 13 | Soldering | 13.1 No cold solder joints, missing solder connections, oxidation or icicle.13.2 No short circuits in components on PCB or FPC. | 2.5 0.65 |



| NO | Item | | Criterion | | AQ | L |
|----|---------------------------------|--|---|---|----|---|
| 14 | Touch Panel Chipped glass | z : Chip thickness $Z \le t$ | y: Chip width z: t: Touch Panel Total t | x: Chip length x≤1/8a | | |
| | | z: Chip thickness $z \le t$ $\odot \text{ Unit: mm}$ $\odot \text{ If there are 2 or m}$ | y: Chip width ≤ 1/2 k and not over viewing area ore chips, x is the total 1 | x: Chip length $x \le 1/8a$ length of each chip | | |



| NO | Item | Criterion | AQL | | |
|----|---|--|-----|--|--|
| 15 | Touch Panel(Fish eye、dent and bubble on film) | $\begin{array}{ c c c }\hline SIZE(mm) & Acceptable Q'ty\\\hline \Phi \leq 0.2 & Accept no dense\\\hline 0.2 < D \leq 0.4 & 5\\\hline 0.4 < D \leq 0.5 & 2\\\hline 0.5 < D & 0\\\hline \end{array}$ | 2.5 | | |
| 16 | Touch Panel Newton ring | Newton ring dimension $\leq 1/2$ touch panel area and not affect font and line distortion($\leq 2.5\%$), it is acceptable. | 2.5 | | |
| 17 | Touch Panel Linearity | Less than 2.5% is acceptable. | 2.5 | | |
| 18 | LCD Ripple | Touch the touch panel, can not see the LCD ripple. Pen: R 1.0mm silicon rubber. Operation Force: 80g | | | |
| 19 | General appearance | 19.1 Pin type must match type in specification sheet. 19.2 LCD pin loose or missing pins. 19.3 Product packaging must the same as specified on packaging specification sheet. 19.4 Product dimension and structure must conform to product specification sheet. | | | |
| 20 | Definition of Pixel | Pixel: Group of Three Sub-pixels (Red, Green, Blue): Dot: Red or Green or Blue or Or Dot: Any sub-pixel Bright Dot Defects Dots (sub-pixels) on display which is bright in the picture and visible at Black Pattern. | | | |



Dark Dot Defects

Dots(sub-pixels) on display which is dark in the picture and visible at

Red/Green/Black/White Pattern.

Neighbour Dot Defects

Two or three neighbour dots (dot: sub-pixel) cluster(R&G,G&B,B&R,or

R&G&B).Dot Defects Inspection Criteria

NOTE: Dot out of VA can be ignored.

| Items | Inspection Criteria | |
|----------------------|---------------------|------------------|
| | Details | Allowed quantity |
| Bright Dot | Not Neighbour Dot | 2 |
| Dark Dot | Not Neighbour Dot | 3 |
| Total acceptable Qty | | 5 |

• Size of dot defect is larger than half of one sub-pixel.

13. Handling Precaution:

13-1 Handling of LCM

- Don't give external shock.
- Don't apply excessive force on the surface.
- Liquid in LCD is hazardous substance. Must not lick and swallow. when the liquid is attach to your hand, skin, cloth etc. Wash it out thoroughly and immediately.
- Don't operate it above the absolute maximum rating.
- Don't disassemble the LCM.
- The operators should be grounded whenever he/she comes into contact with the module. Never touch any of the conductive parts such as the LSI pads, the copper leads on the PCB and the interface terminals with any parts of the human body.
- The modules should be kept in antistatic bags or other containers resistant to static for storage.
- The module is coated with a film to protect the display surface. Be care when peeling off this protective film since static electricity may be generated.

13-2 Storage

- Store in an ambient temperature of 25±10°C, and in a relative humidity of 50±10%RH. Don't expose to sunlight or fluorescent light.
- Storage in a clean environment, free from dust, active gas, and solvent.
- Store in anti-static electricity container.
- Store without any physical load.

13-3 Soldering

- Use only soldering irons with proper grounding and no leakage.
- Iron: No higher than 280±10°C and less than 3 sec during Hand soldering.
- Rewiring: no more than 2 times.

14. Guarantee:

Our products meet requirements of the environment.

YEEBO ROHS requirement is based on European Union Directive 2011/65/EU (ROHS) Requirements and Update.